INTEGRATED CIRCUITS



Product specification IC05 Data Handbook 1991 Feb 08



Philips Semiconductors

74ALS373/74ALS374

Latch/flip-flop

74ALS373	Octal transparent latch (3-State)
74ALS374	Octal D flip-flop (3-State)

FEATURES

- 8-bit transparent latch 74ALS373
- 8-bit positive edge triggered register 74ALS374
- 3-State output buffers
- Common 3-State output register
- Independent register and 3-State buffer operation

TYPE	TYPICAL PROPAGATION DELAY	TYPICAL SUPPLY CURRENT (TOTAL)
74ALS373	6.0ns	14mA

ТҮРЕ	TYPICAL f _{MAX}	TYPICAL SUPPLY CURRENT (TOTAL)
74ALS374	50MHz	17mA

ORDERING INFORMATION

	ORDER CODE	
DESCRIPTION	COMMERCIAL RANGE V _{CC} = 5V ±10%, T _{amb} = 0°C to +70°C	DRAWING NUMBER
20-pin plastic DIP	74ALS373N, 74ALS374N	SOT146-1
20-pin plastic SOL	74ALS373D, 74ALS374D	SOT163-1
20-pin plastic SSOP Type II	74ALS373DB, 74ALS374DB	SOT339-1

INPUT AND OUTPUT LOADING AND FAN-OUT TABLE

DESCRIPTION

The 74ALS373 is an octal transparent latch coupled to eight 3-State output devices. The two sections of the device are controlled independently by enable (E) and output enable (OE) control gates.

The data on the D inputs is transferred to the latch outputs when the enable (E) input is High. The latch remains transparent to the data input while E is High, and stores the data that is present one setup time before the High-to-Low enable transition.

The 3-State output buffers are designed to drive heavily loaded 3-State buses, MOS memories, or MOS microprocessors.

The active-Low output enable (OE) controls all eight 3-State buffers independent of the latch operation. When OE is Low, latched or transparent data appears at the output.

When OE is High, the outputs are in High impedance "off" state, which means they will neither drive nor load the bus.

The 74ALS374 is an 8-bit edge triggered register coupled to eight 3-State output buffers. The two sections of the device are controlled independently by clock (CP) and output enable (OE) control gates.

The register is fully edge triggered. The state of the D input, one setup time before the Low-to-High clock transition is transferred to the corresponding flip-flop's Q output.

The 3-State output buffers are designed to drive heavily loaded 3-State buses, MOS memories, or MOS microprocessors.

The active-Low output enable (OE) controls all eight 3-State buffers independent of the register operation. When OE is Low, the data in the register appears at the outputs. When OE is High, the outputs are in High impedance "off" state, which means they will neither drive nor load the bus.

PINS	DESCRIPTION	74ALS (U.L.) HIGH/LOW	LOAD VALUE HIGH/LOW
D0 – D7	Data inputs	1.0/1.0	20µA/0.1mA
E (74ALS373)	Enable input (active-High)	1.0/1.0	20µA/0.1mA
OE	Output enable inputs (active-Low)	1.0/1.0	20µA/0.1mA
CP (74ALS374)	Clock pulse input (active rising edge)	1.0/1.0	20µA/0.1mA
Q0 – Q7	3-State outputs	130/240	2.6mA/24mA

NOTE: One (1.0) ALS unit load is defined as: 20µA in the High state and 0.1mA in the Low state.

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PIN CONFIGURATION – 74ALS373



LOGIC SYMBOL – 74ALS373



IEC/IEEE SYMBOL – 74ALS373



PIN CONFIGURATION – 74ALS374



LOGIC SYMBOL – 74ALS374



IEC/IEEE SYMBOL – 74ALS374



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LOGIC DIAGRAM - 74ALS373



FUNCTION TABLE – 74ALS373

	INPUTS		INTERNAL REGISTER	OUTPUTS	
ŌĒ	E	Dn	INTERNAL REGISTER	Q0 – Q7	OPERATING MODE
L	Н	L	L	L	Enable and read register
L	Н	Н	Н	Н	Enable and read register
L	\downarrow	I	L	L	Latch and read register
L	\downarrow	h	Н	Н	Laten and read register
L	L	Х	NC	NC	Hold
Н	L	Х	NC	Z	Diaphla autouta
Н	Н	Dn	Dn	Z	Disable outputs

H = High-voltage level

h = High state must be present one setup time before the High-to-Low enable transition

Low-voltage level L =

Low state must be present one setup time before the High-to-Low enable transition L =

NC= No change

High impedance "off" state

 $\begin{array}{rcl} X &= & \text{Don't care} \\ Z &= & \text{High imped} \\ \downarrow &= & \text{High-to-Low} \end{array}$ High-to-Low enable transition

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LOGIC DIAGRAM - 74ALS374



FUNCTION TABLE – 74ALS374

	INPUTS		INTERNAL REGISTER	OUTPUTS	OPERATING MODE
OE	СР	Dn	Q0 - Q7		OPERATING MODE
L	\uparrow	I	L	L	Load and read register
L	\uparrow	h	Н	Н	Load and read register
L	\$	Х	NC	NC	Hold
Н	\$	Х	NC	Z	Diaphla autouta
Н	\uparrow	Dn	Dn	Z	Disable outputs

High-voltage level H =

= High state must be present one setup time before the Low-to-High clock transition h

 Low-voltage level L

L Low state must be present one setup time before the Low-to-High clock transition =

NC= No change

X = Don't care

 High impedance "off" state
Low-to-High clock transition Z ↑

₽ Not Low-to-High clock transition =

ABSOLUTE MAXIMUM RATINGS

(Operation beyond the limit set forth in this table may impair the useful life of the device. Unless otherwise noted these limits are over the operating free-air temperature range.)

SYMBOL	PARAMETER	RATING	UNIT
V _{CC}	Supply voltage	-0.5 to +7.0	V
V _{IN}	Input voltage	-0.5 to +7.0	V
I _{IN}	Input current	-30 to +5	mA
V _{OUT}	Voltage applied to output in High output state	–0.5 to V_{CC}	V
I _{OUT}	Current applied to output in Low output state	48	mA
T _{amb}	Operating free-air temperature range	0 to +70	°C
T _{stg}	Storage temperature range	-65 to +150	°C

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RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER		LIMITS			
STWBOL	FARAMETER	MIN	NOM	MAX	UNIT	
V _{CC}	Supply voltage	4.5	5.0	5.5	V	
V _{IH}	High-level input voltage	2.0			V	
V _{IL}	Low-level input voltage			0.8	V	
I _{IK}	Input clamp current			-18	mA	
I _{ОН}	High-level output current			-2.6	mA	
I _{OL}	Low-level output current			24	mA	
T _{amb}	Operating free-air temperature range	0		+70	°C	

DC ELECTRICAL CHARACTERISTICS

(Over recommended operating free-air temperature range unless otherwise noted.)

	PARAMETER		TEAT CONDITI	LIMITS					
SYMBOL	PARAN	IETER		TEST CONDITIO				MAX	UNIT
M		~~		$V_{CC} = \pm 10\%, V_{IL} = MAX,$ $I_{OH} = -0.4mA$		$V_{CC} - 2$			V
V _{OH}	High-level output volta	ge		V _{IH} = MIN	I _{OH} = MAX	2.4	3.2		V
Va	Low-level output voltage	10		$V_{CC} = MIN, V_{IL} = MAX,$	I _{OL} = 12mA		0.25	0.40	V
V _{OL}		Je		V _{IH} = MIN	I _{OL} = 24mA		0.35	0.50	V
V _{IK}	Input clamp voltage			$V_{CC} = MIN, I_I = I_{IK}$			-0.73	-1.2	V
l _l	Input current at maxim	um input volta	ige	$V_{CC} = MAX, V_I = 7.0V$				0.1	mA
I _{IH}	High-level input curren	t		$V_{CC} = MAX, V_I = 2.7V$				20	μΑ
L.	Low-level input	74ALS3	373	V _{CC} = MAX, V _I = 0.4V				-0.1	mA
٩L	Low lover input current	74ALS3	374	$V_{\rm CC} = WAX, V_{\rm I} = 0.4V$				-0.2	mA
I _{OZH}		Off-state output current, High-level voltage applied		$V_{CC} = MAX, V_I = 2.7V$				20	μA
I _{OZL}	Off-state output curren Low-level voltage appli			$V_{CC} = MAX, V_I = 0.4V$				-20	μA
Ι _Ο	Output current ³			$V_{CC} = MAX, V_O = 2.25V$		-30		-112	mA
			I _{CCH}				7	16	mA
		74ALS373	I _{CCL}	V _{CC} = MAX			14	25	mA
			I _{CCZ}]			17	27	mA
ICC	I _{CC} Supply current (total)		I _{CCH}				11	19	mA
		74ALS374 I _{CCL}	I _{CCL}	V _{CC} = MAX			19	29	mA
			I _{CCZ}]			20	31	mA

NOTES:

1. For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable type. 2. All typical values are at $V_{CC} = 5V$, $T_{amb} = 25^{\circ}C$. 3. The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, I_{OS} .

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AC ELECTRICAL CHARACTERISTICS

				LIM	ITS	
SYMBOL	SYMBOL PARAMETER		TEST CONDITION		$\begin{array}{c} \textbf{T}_{amb} = 0^\circ \textbf{C} \ \textbf{to} \ \textbf{+70}^\circ \textbf{C} \\ \textbf{V}_{CC} = \textbf{+5.0V} \pm 10\% \\ \textbf{C}_L = 50 \textbf{pF}, \ \textbf{R}_L = 500 \Omega \end{array}$	
				MIN	MAX	1
t _{PLH} t _{PHL}	Propagation delay Dn to Qn		Waveform 3	2.0 2.0	12.0 14.0	ns
t _{PLH} t _{PHL}	Propagation delay E to Qn	7441 6070	Waveform 2	3.0 3.0	14.0 14.0	ns
t _{PZH} t _{PZL}	Output enable time to High or Low level	74ALS373	Waveform 6 Waveform 7	2.0 3.0	14.0 14.0	ns
t _{PHZ} t _{PLZ}	Output disable time from High or Low level		Waveform 6 Waveform 7	2.0 2.0	10.0 12.0	ns
f _{MAX}	Maximum clock frequency		Waveform 1	50		MHz
t _{PLH} t _{PHL}	Propagation delay CP to Qn		Waveform 1	3.0 4.0	12.0 14.0	ns
t _{PZH} t _{PZL}	Output enable time to High or Low level	74ALS374	Waveform 6 Waveform 7	3.0 3.0	9.0 11.0	ns
t _{PHZ} t _{PLZ}	Output disable time from High or Low level		Waveform 6 Waveform 7	2.0 3.0	10.0 12.0	ns

AC SETUP REQUIREMENTS

				LIM		
SYMBOL	SYMBOL PARAMETER		TEST CONDITION	T _{amb} = 0°C V _{CC} = +5. C _L = 50pF,		UNIT
				MIN	МАХ	1
t _{su} (H) t _{su} (L)	Setup time, High or Low Dn to E		Waveform 4	6.0 6.0		ns
t _h (H) t _h (L)	Hold time, High or Low Dn to E	74ALS373	Waveform 4	6.0 6.0		ns
t _w (H)	E Pulse width, High		Waveform 2	10.0		ns
t _{su} (H) t _{su} (L)	Setup time, High or Low Dn to CP		Waveform 5	6.0 6.0		ns
t _h (H) t _h (L)	Hold time, High or Low Dn to CP	74ALS374	Waveform 5	1.0 1.0		ns
t _w (H) t _w (L)	CP Pulse width, High or Low		Waveform 1	10.0 10.0		ns

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AC WAVEFORMS

For all waveforms, $V_M = 1.3V$.

The shaded areas indicate when the input is permitted to change for predictable output performance.



Waveform 1. Propagation Delay for Clock Input to Output, Clock Pulse Widths, and Maximum Clock Frequency



Waveform 3. Propagation Delay for Data to Output



Waveform 4. Data Setup Time and Hold Times



Waveform 6. 3-State Output Enable Time to High Level and Output Disable Time from High Level



Waveform 2. Propagation Delay for Enable to Output and Enable Pulse Width



Waveform 5. Data Setup Time and Hold Times



Waveform 7. 3-State Output Enable Time to Low Level and Output Disable Time from Low Level

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TEST CIRCUIT AND WAVEFORMS





SOT146-1

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DIMENSIONS (inch dimensions are derived from the original mm dimensions)

UNIT	A max.	A ₁ min.	A ₂ max.	b	b ₁	с	D ⁽¹⁾	E ⁽¹⁾	e	e ₁	L	M _E	M _H	w	Z ⁽¹⁾ max.
mm	4.2	0.51	3.2	1.73 1.30	0.53 0.38	0.36 0.23	26.92 26.54	6.40 6.22	2.54	7.62	3.60 3.05	8.25 7.80	10.0 8.3	0.254	2.0
inches	0.17	0.020	0.13	0.068 0.051	0.021 0.015	0.014 0.009	1.060 1.045	0.25 0.24	0.10	0.30	0.14 0.12	0.32 0.31	0.39 0.33	0.01	0.078

Note

1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE VERSION		REFER	EUROPEAN	ISSUE DATE			
	RSION	IEC	JEDEC	EIAJ		PROJECTION	1350E DATE
SOT	146-1			SC603		\bigcirc	-92-11-17 95-05-24

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Note

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.

OUTLINE VERSION		REFER	EUROPEAN	ISSUE DATE		
	IEC	JEDEC	EIAJ		PROJECTION	1350E DATE
SOT163-1	075E04	MS-013AC				-92-11-17 95-01-24

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DEFINITIONS					
Data Sheet Identification	Product Status	Definition			
Objective Specification	Formative or in Design	This data sheet contains the design target or goal specifications for product development. Specifications may change in any manner without notice.			
Preliminary Specification	Preproduction Product	This data sheet contains preliminary data, and supplementary data will be published at a later date. Philips Semiconductors reserves the right to make changes at any time without notice in order to improve design and supply the best possible product.			
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